


<p>Search Notes</p> 	<p>Application/Control No.</p> <p>10612222</p>	<p>Applicant(s)/Patent Under Reexamination</p> <p>AKAGAWA ET AL.</p>
	<p>Examiner</p> <p>Chang, Rick K</p>	<p>Art Unit</p> <p>3729</p>


Notes	Date	Examiner
-------	------	----------

east search

7/6/06

rc

U.S. Patent and Trademark Office	Part of Paper No.: 20060706
----------------------------------	-----------------------------

<p>Searched</p> 	<p>Application/Control No.</p> <p>10612222</p>	<p>Applicant(s)/Patent Under Reexamination</p> <p>AKAGAWA ET AL.</p>
	<p>Examiner</p> <p>Chang, Rick K</p>	<p>Art Unit</p> <p>3729</p>

Class	SubClass	Date	Examiner
-------	----------	------	----------

search updated

7/6/06

rc

U.S. Patent and Trademark Office	Part of Paper No.: 20060706
----------------------------------	-----------------------------